

<b>Notice of References Cited</b>	Application/Control No. 10/676,294	Applicant(s)/Patent Under Reexamination GOLZARIAN ET AL.	
	Examiner Thanh V. Pham	Art Unit 2823	Page 1 of 1

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	B	US-2004/0057191	03-2004	Timonov et al.	361/302
	C	US-4,233,671	11-1980	Gerzberg et al.	365/105
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Kawagishi et al., "Novel Electrical, Optical and Rheological Properties of Conducting Polymer in Liquids and Solutions Infiltrated in Opals and Inverse Opals", 13 <sup>th</sup> International Conference on Dielectric Liquids, Nara, Japan, July 20-25, 1999.
	V	Ruschau et al., "Percolation Constraints in the Use of Conductor-Filled Polymers for Interconnects", 1992 IEEE, pp 481-486.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.